December 2001



FDG316P P-Channel Logic Level PowerTrench[®] MOSFET

General Description

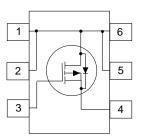
This P-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Applications

- DC/DC converter
- Load switch
- Power Management

SC70-6



• -1.6 A, -30 V. $\rm R_{\rm DS(ON)}=0.19~\Omega~$ @ $\rm V_{\rm GS}=-10~V$

• High performance trench technology for extremely low

Compact industry standard SC70-6 surface mount

• Low gate charge (3.5nC typical).

 $\mathsf{R}_{\rm DS(ON)}$ = 0.30 Ω @ $\mathsf{V}_{\rm GS}$ = -4.5 V.

Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DSS}	Drain-Source Voltage			-30	V	
V _{GSS}	Gate-Source Voltage			±20	V	
ID	Drain Current - Continuous (Note 1a)			-1.6	A	
	- Pulsed			-6		
P _D	Power Dissipation for Single Operation		(Note 1a)	0.75	W	
			(Note 1b)	0.48		
	l Character		ture Range	-55 to +150	°C	
	l Character	<u> </u>	ture Range		°C/W	
Therma R₀JA	I Character	istics	ture Range	-55 to +150	-	
Therma _{R_{əJA} Packag}	I Character	istics ance, Junction-to-Ambient	ture Range	-55 to +150	-	

Features

 $\mathsf{R}_{\mathsf{DS}(\mathsf{ON})}.$

package.

0	Demonster	Test Conditions		-		11
Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Off Chara	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = -250 \mu A$	-30			V
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		-34		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-1	μA
I _{GSS}	Gate-Body Leakage Forward	$V_{GS} = 16 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I _{GSS}	Gate-Body Leakage Reverse	$V_{GS} = -16 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	-1	-1.6	-3	V
$\Delta V_{GS(th)} \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		3.5		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	$ \begin{array}{l} V_{GS}=-10 \ V, \ I_{D}=-1.6 \ A \\ V_{GS}=-10 \ V, \ I_{D}=-1.6 \ A, T_{J}=125^{\circ}C \\ V_{GS}=-4.5 \ V, \ I_{D}=-1.3 \ A \end{array} $		0.16 0.22 0.23	0.19 0.31 0.30	Ω
I _{D(on)}	On-State Drain Current	V _{GS} = -4.5 V, V _{DS} = -5 V	-3			Α
g fs	Forward Transconductance	$V_{DS} = -5 \text{ V}, \text{ I}_{D} = -0.5 \text{ A}$		3		S
Dvnamic	Characteristics					
Ciss	Input Capacitance	$V_{DS} = -15 V, V_{GS} = 0 V,$		165		pF
Coss	Output Capacitance	f = 1.0 MHz		60		pF
C _{rss}	Reverse Transfer Capacitance			25		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -15 V, I_D = -1 A,$		8	20	ns
tr	Turn-On Rise Time	V_{GS} = -10 V, R_{GEN} = 6 Ω		9	20	ns
t _{d(off)}	Turn-Off Delay Time	1		14	30	ns
t _f	Turn-Off Fall Time	1		2	10	ns
Qg	Total Gate Charge	$V_{DS} = -15 \text{ V}, \text{ I}_{D} = -1.6 \text{ A},$		3.5	5	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V		0.6		nC
Q _{gd}	Gate-Drain Charge	1		0.8		nC

Maximum Continuous Drain-Source Diode Forward Current

of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

 $V_{GS} = 0 V, I_S = -0.42 A$

1. R_{6JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface

Drain-Source Diode Forward

Voltage

a) 170°C/W when mounted on a 1 in² pad of 2oz copper. b) 260°C/W when mounted on a minimum pad. 2. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2.0%

ls

 V_{SD}

Notes:

FDG316P Rev. D

-0.42

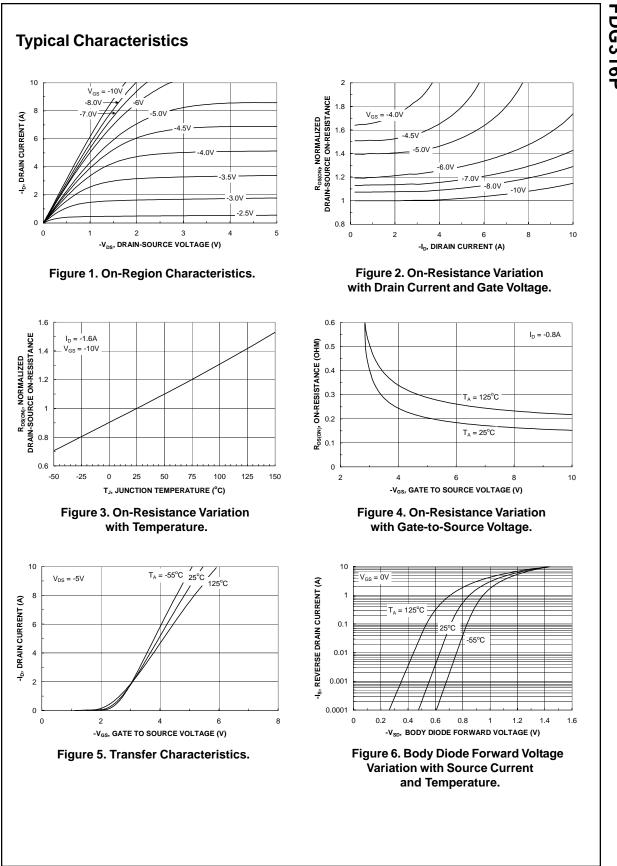
-1.2

0.75

(Note 2)

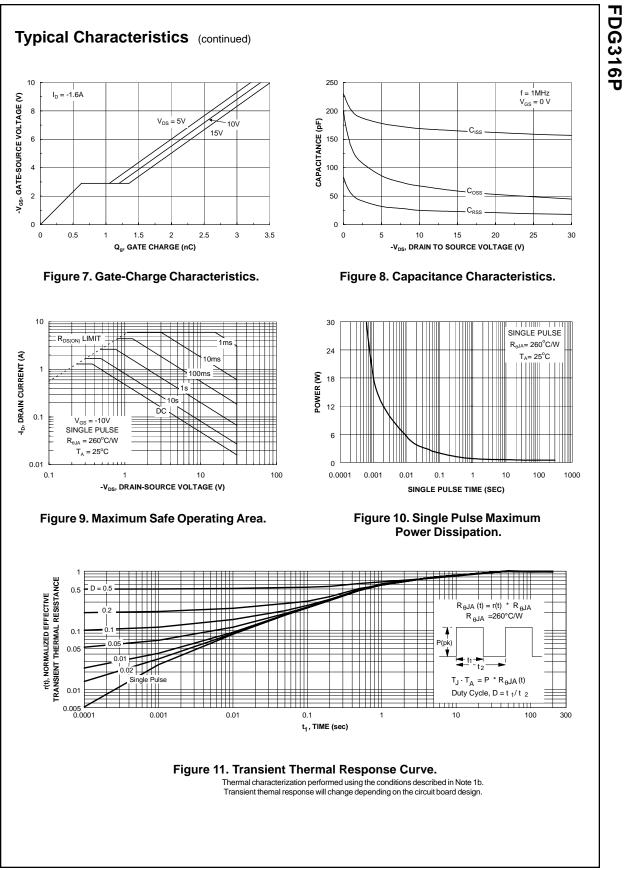
А

V



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FDG316P



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